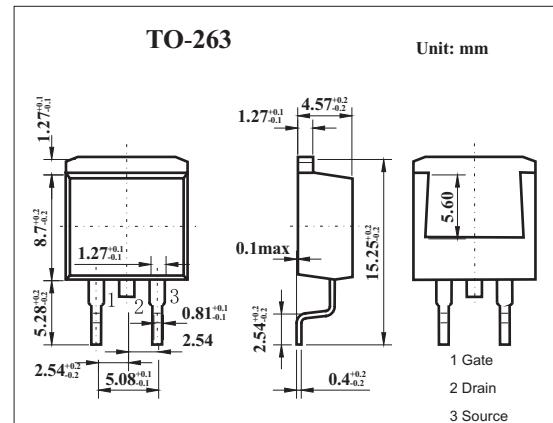


MOS Field Effect Transistor

2SK3322

■ Features

- Low gate charge
 $Q_G = 15 \text{ nC TYP. } (V_{DD} = 450\text{V}, V_{GS} = 10 \text{ V}, I_D = 5.5\text{A})$
- Gate voltage rating $\pm 30 \text{ V}$
- Low on-state resistance
 $R_{DS(on)} = 2.2 \Omega \text{ MAX. } (V_{GS} = 10 \text{ V}, I_D = 2.8\text{A})$
- Avalanche capability ratings



■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Drain to source voltage	V_{DSS}	600	V
Gate to source voltage	V_{GSS}	± 30	V
Drain current	I_D	± 5.5	A
	I_{Dp}^*	± 20	A
Power dissipation $T_A=25^\circ\text{C}$	P_D	1.5	W
$T_c=25^\circ\text{C}$		65	
Channel temperature	T_{ch}	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to +150	$^\circ\text{C}$

* $PW \leq 10 \mu\text{s, Duty Cycle} \leq 1\%$

■ Electrical Characteristics $T_a = 25^\circ\text{C}$

Parameter	Symbol	Testconditions	Min	Typ	Max	Unit
Drain cut-off current	I_{DSS}	$V_{DS}=600\text{V}, V_{GS}=0$			100	μA
Gate leakage current	I_{GSS}	$V_{GS}=\pm 30\text{V}, V_{DS}=0$			± 10	μA
Gat cutoff voltage	$V_{GS(off)}$	$V_{DS}=10\text{V}, I_D=1\text{mA}$	2.5		3.5	V
Forward transfer admittance	$ Y_{fs} $	$V_{DS}=10\text{V}, I_D=2.8\text{A}$	1.0			S
Drain to source on-state resistance	$R_{DS(on)}$	$V_{GS}=10\text{V}, I_D=2.8\text{A}$		1.7	2.2	Ω
Input capacitance	C_{iss}	$V_{DS}=10\text{V}, V_{GS}=0, f=1\text{MHz}$		550		pF
Output capacitance	C_{oss}			115		pF
Reverse transfer capacitance	C_{rss}			13		pF
Turn-on delay time	t_{on}	$I_D=2.8\text{A}, V_{GS(on)}=10\text{V}, R_G=10\Omega, V_{DD}=150\text{V}$		12		ns
Rise time	t_r			10		ns
Turn-off delay time	t_{off}			35		ns
Fall time	t_f			12		ns